S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/687,835	THIESEN ET AL.	
Examiner	Art Unit	
Trinh T. Nauven	3644	

	SEARCHED		
Class	Subclass	Date	Examiner
updated	searches	3/3/2006	TTN
as on	search		
note	9/14/05		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCI	OTES H STRATEGY	′)
	DATE	EXMR